

•General Description

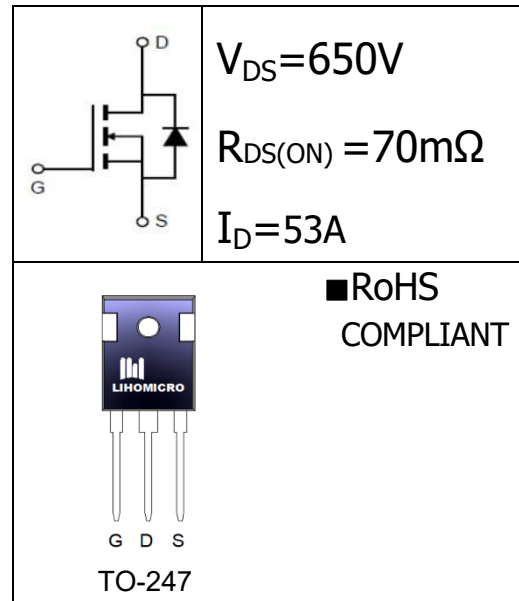
The SJ MOSFET LH65R070FD has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device offers extremely fast and robust body diode, and is suitable for telecom and power supplies.

•Features

- 100% Avalanche Tested
- Low Power Loss By High Speed Switching
- Low On-Resistance

•Application

- DC-DC Converter
- UPS-Micro Inverter System
- PFC Power Supply


•Ordering Information:

Part number	LH65R070FD
Package	TO-247
Basic ordering unit (pcs)	330
Normal Package Material Ordering Code	LH65R070FDT2-T0247-TU
Halogen Free Ordering Code	LH65R070FDT2-T0247-TU-HF

•Absolute Maximum Ratings (TC =25°C)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D $T_C = 25^\circ C$	53	A
	I_D $T_C = 100^\circ C$	34	
Pulsed drain current ($T_C = 25^\circ C$, t_p limited by T_{imax}) ¹	$I_{D \text{ pulse}}$	160	A
Power Dissipation($T_C=25^\circ C$)	P_D	391	W
Single Pulse Avalanche Energy ²	E_{AS}	1165	mJ
Repetitive Avalanche Energy ²	E_{AR}	1.78	mJ
Operating Junction Temperature	T_J	-55...+150	°C
Storage Temperature	T_{STG}	-55...+150	°C

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS}=0V, I_D=250\mu A$	650			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0		4.0	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V,$ $T_J=25^\circ C$ $T_J=150^\circ C$			1	μA
					100	nA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=+30V, V_{DS}=-30V$			± 100	nA
Drain-Source On State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=25A$		60	70	m Ω
Rate resistance	R_G	f=1.0MHz open drain		2.4		Ω

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=50V$ F = 1MHz		4420		pF
Output capacitance	C_{oss}			2960		
Reverse transfer capacitance	C_{rss}			166		
Turn -Off Delay Time	$T_{d(off)}$	$V_{DD}=400V,$ $I_D=53A, R_G=25\Omega$		410		ns
Turn-on delay time	$T_{d(on)}$			68		
Rise time	T_r			202		
Fall time	T_f			160		
Total Gate Charge	Q_g	$I_D=53A, V_{DS}=480V$ $V_{GS}=10V$		132		nC
Gate-to-Source Charge	Q_{gs}			30		
Gate-to-Drain Charge	Q_{gd}			58		
Diode Forward Voltage	V_{SD}	$I_D=47A$ $V_{GS}=0V$			1.4	V
Body Diode Reverse Recovery Time	T_{rr}	$I_D=23A,$ $V_{ds}=520V$		198		ns
Body Diode Reverse Recovery Charge	Q_{rr}			13.7		nC
Peak Reverse Recovery Current	I_{rrm}			47		A

●Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}		0.32		$^\circ C/W$
Thermal resistance, junction - ambient	R_{thJA}		62.5		$^\circ C/W$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS}=10A, V_{DD}=50V, R_G=25\Omega$, Starting $T_J=25^\circ C$

• **Typical Characteristics**

Figure 1. Output Characteristics

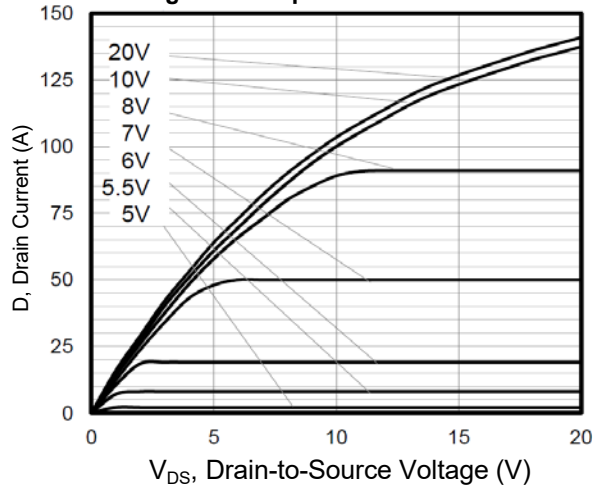


Figure 2. Transfer Characteristics

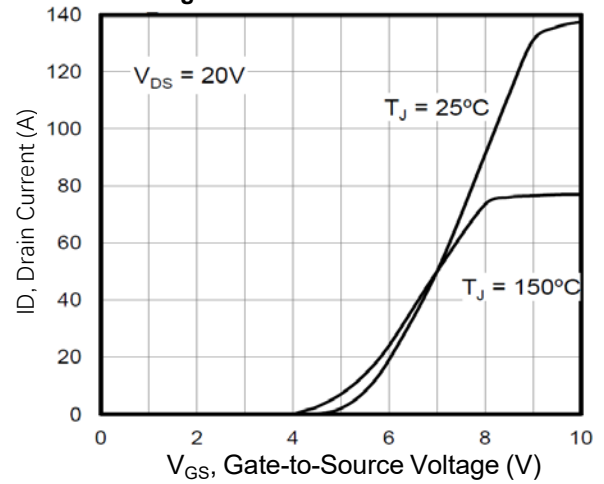


Figure 3. On-Resistance vs. Drain Current

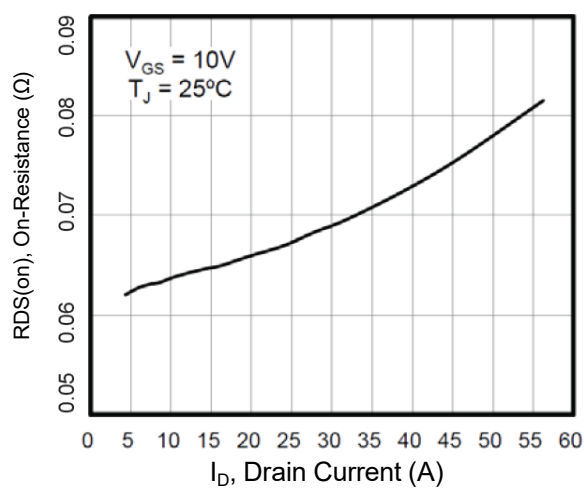


Figure 4. Capacitance

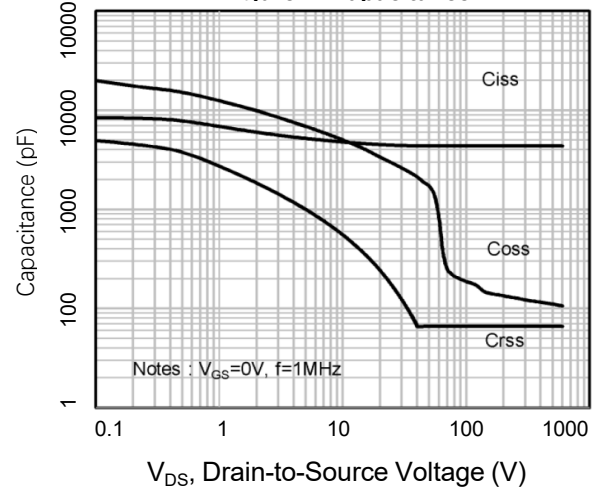


Figure 5. GateCharge Characteristics

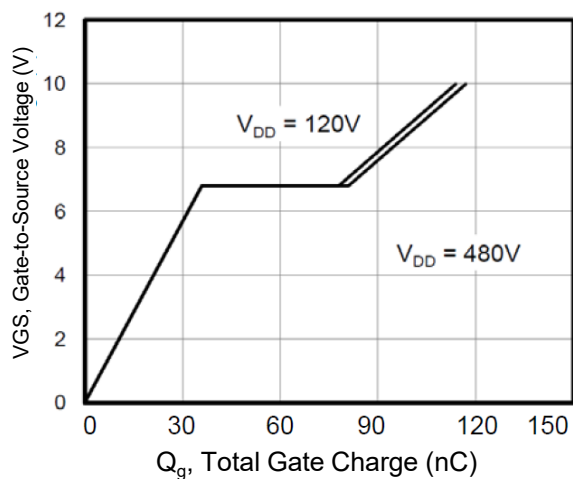
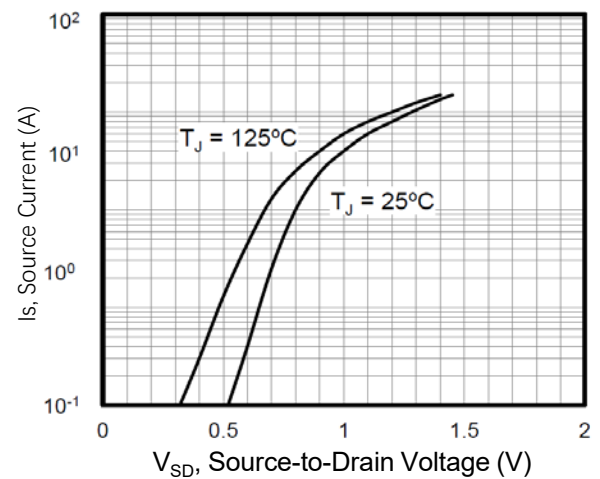


Figure 6. Body Diode Forward



Typical Characteristics (cont.)

Figure 7. On-Resistance vs. Junction Temperature

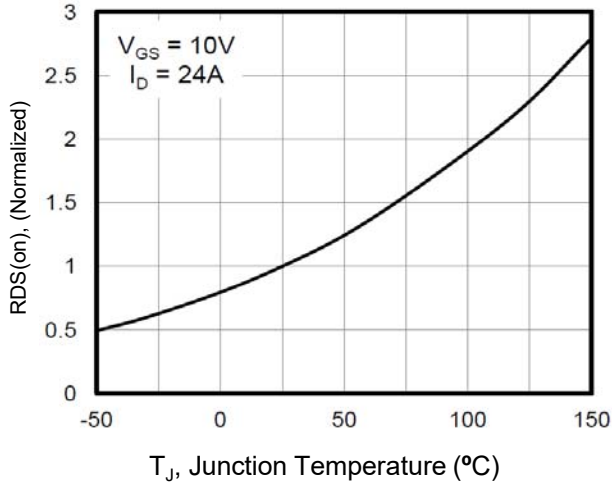


Figure 8. Breakdown voltage vs. Junction Temperature

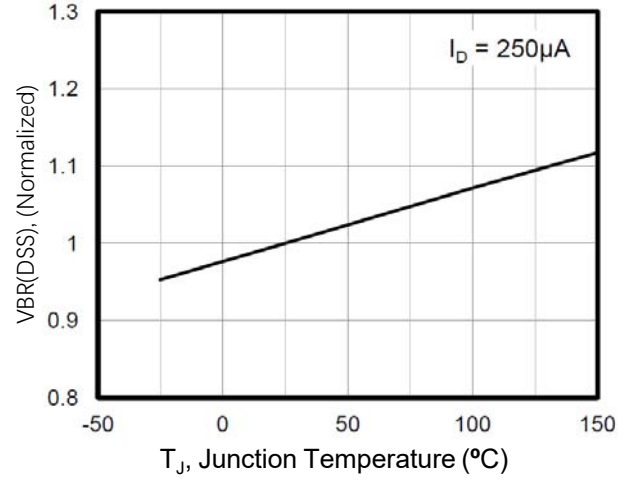


Figure 9. Transient Thermal Impedance for TO-247

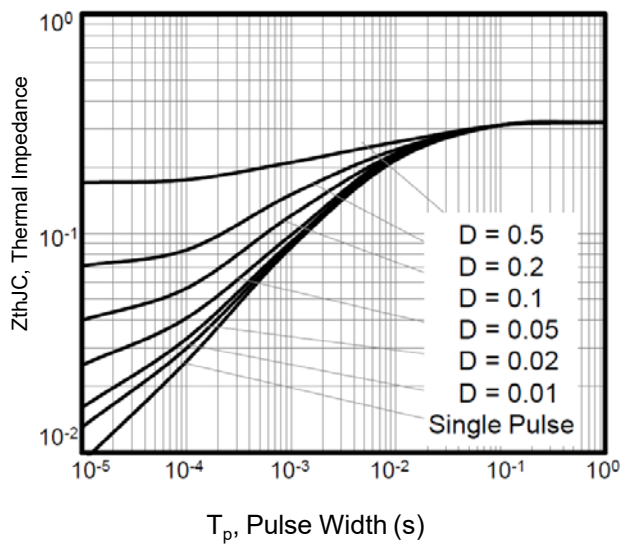
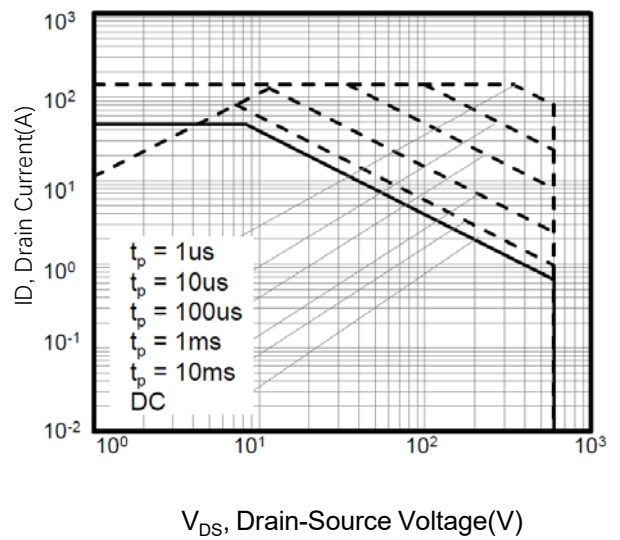


Figure 10. Safe operation area for TO-247



● **Test Circuits & Waveforms**

Figure A: Gate Charge Test Circuit and Waveform

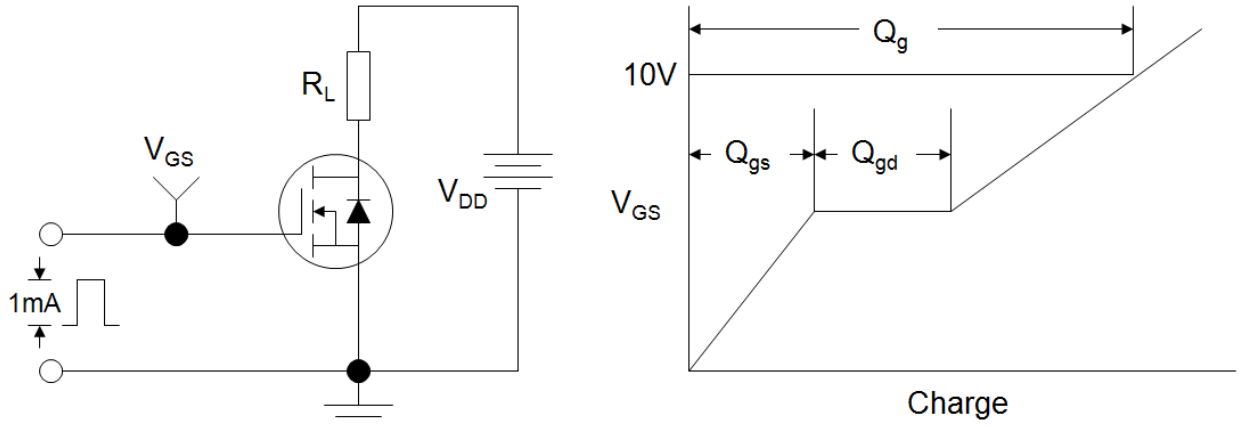


Figure B: Resistive Switching Test Circuit and Waveform

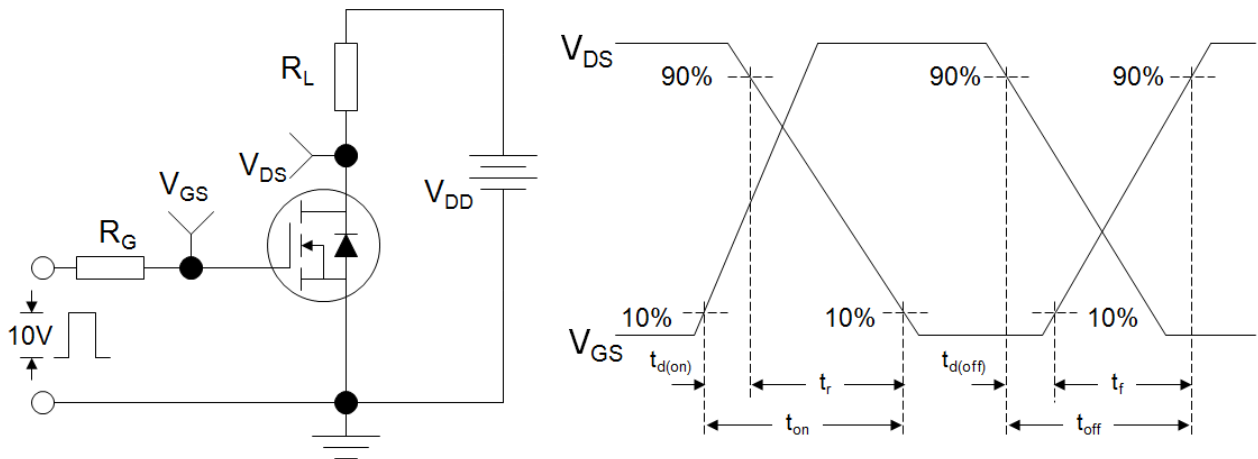
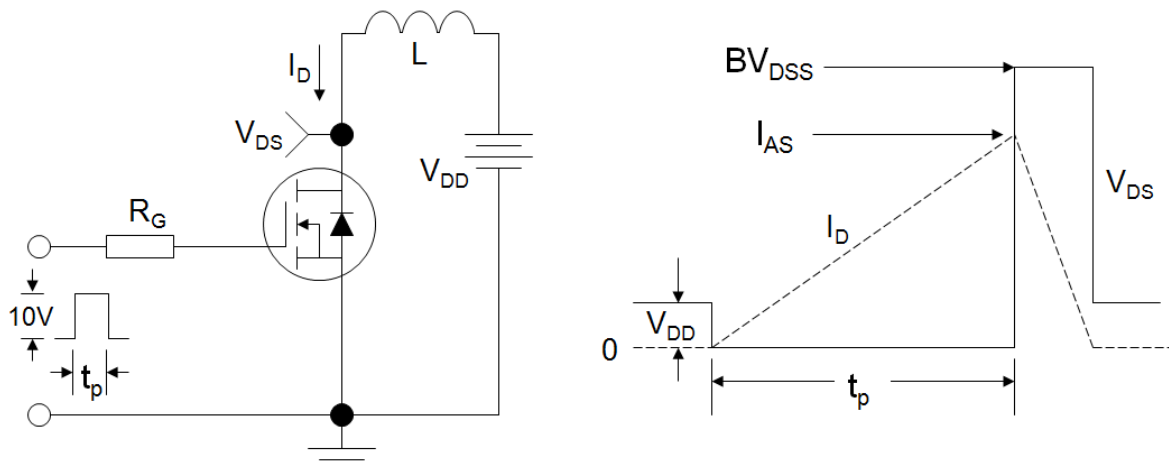


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



●Dimensions (TO-247)

UNIT:mm

SYMBOL	min	max	SYMBOL	min	max
A	15.60	16.00	G2	1.95	2.25
B	20.80	21.20	N	5.25	5.65
C	4.85	5.15	L1	4.00	4.30
D	1.85	2.15	L	19.60	20.40
E	1.00	1.40	I	2.30	2.50
F	0.50	0.70	ΦP	3.30	3.70
G1	3.00	3.30			

